

ISL9V5036S3ST / ISL9V5036P3 / ISL9V5036S3

EcoSPARK™ 500mJ, 360V, N-Channel Ignition IGBT

General Description

The ISL9V5036S3ST, ISL9V5036P3, and ISL9V5036S3 are the next generation IGBTs that offer outstanding SCIS capability in the D²-Pak (TO-263) and TO-220 plastic package. These devices are intended for use in automotive ignition circuits, specifically as coil drivers. Internal diodes provide voltage clamping without the need for external components.

EcoSPARK™ devices can be custom made to specific clamp voltages. Contact your nearest Fairchild sales office for more information.

Formerly Developmental Type 49443

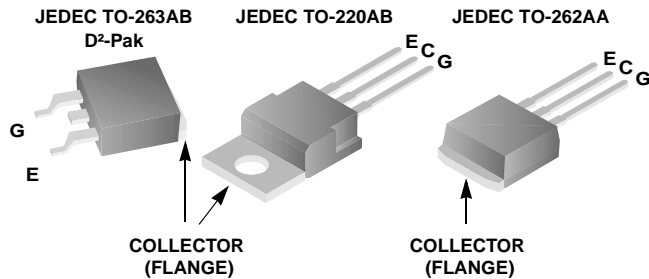
Applications

- Automotive Ignition Coil Driver Circuits
- Coil-On Plug Applications

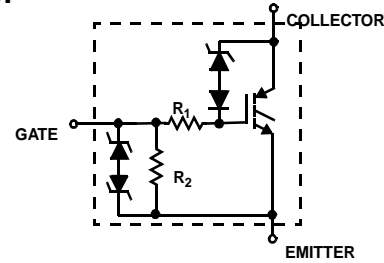
Features

- Industry Standard D²-Pak package
- SCIS Energy = 500mJ at T_J = 25°C
- Logic Level Gate Drive

Package



Symbol



Device Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
BV _{CEB}	Collector to Emitter Breakdown Voltage (I _C = 1 mA)	390	V
BV _{ECS}	Emitter to Collector Voltage - Reverse Battery Condition (I _C = 10 mA)	24	V
E _{SCIS25}	At Starting T _J = 25°C, I _{SCIS} = 38.5A, L = 670 µHy	500	mJ
E _{SCIS150}	At Starting T _J = 150°C, I _{SCIS} = 30A, L = 670 µHy	300	mJ
I _{C25}	Collector Current Continuous, At T _C = 25°C, See Fig 9	46	A
I _{C110}	Collector Current Continuous, At T _C = 110°C, See Fig 9	31	A
V _{GEM}	Gate to Emitter Voltage Continuous	±10	V
P _D	Power Dissipation Total T _C = 25°C	250	W
	Power Dissipation Derating T _C > 25°C	1.67	W/°C
T _J	Operating Junction Temperature Range	-40 to 175	°C
T _{STG}	Storage Junction Temperature Range	-40 to 175	°C
T _I	Max Lead Temp for Soldering (Leads at 1.6mm from Case for 10s)	300	°C
T _{pkg}	Max Lead Temp for Soldering (Package Body for 10s)	260	°C
ESD	Electrostatic Discharge Voltage at 100pF, 1500Ω	4	kV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
V5036S	ISL9V5036S3ST	TO-263AB	330mm	24mm	800
V5036P	ISL9V5036P3	TO-220AA	Tube	N/A	50
V5036S	ISL9V5036S3	TO-262AA	Tube	N/A	50

Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

Off State Characteristics

BV_{CER}	Collector to Emitter Breakdown Voltage	$I_C = 2\text{mA}$, $V_{\text{GE}} = 0$, $R_G = 1\text{K}\Omega$, See Fig. 15 $T_J = -40$ to 150°C	330	360	390	V
BV_{CES}	Collector to Emitter Breakdown Voltage	$I_C = 10\text{mA}$, $V_{\text{GE}} = 0$, $R_G = 0$, See Fig. 15 $T_J = -40$ to 150°C	360	390	420	V
BV_{ECS}	Emitter to Collector Breakdown Voltage	$I_C = -75\text{mA}$, $V_{\text{GE}} = 0\text{V}$, $T_C = 25^\circ\text{C}$	30	-	-	V
BV_{GES}	Gate to Emitter Breakdown Voltage	$I_{\text{GES}} = \pm 2\text{mA}$	± 12	± 14	-	V
I_{CER}	Collector to Emitter Leakage Current	$V_{\text{CER}} = 250\text{V}$, $R_G = 1\text{K}\Omega$, See Fig. 11	$T_C = 25^\circ\text{C}$	-	-	25 μA
			$T_C = 150^\circ\text{C}$	-	-	1 mA
I_{ECS}	Emitter to Collector Leakage Current	$V_{\text{EC}} = 24\text{V}$, See Fig. 11	$T_C = 25^\circ\text{C}$	-	-	1 mA
			$T_C = 150^\circ\text{C}$	-	-	40 mA
R_1	Series Gate Resistance		-	75	-	Ω
R_2	Gate to Emitter Resistance		10K	-	30K	Ω

On State Characteristics

$V_{\text{CE(SAT)}}$	Collector to Emitter Saturation Voltage	$I_C = 10\text{A}$, $V_{\text{GE}} = 4.0\text{V}$	$T_C = 25^\circ\text{C}$, See Fig. 4	-	1.17	1.60	V
$V_{\text{CE(SAT)}}$	Collector to Emitter Saturation Voltage	$I_C = 15\text{A}$, $V_{\text{GE}} = 4.5\text{V}$	$T_C = 150^\circ\text{C}$	-	1.50	1.80	V

Dynamic Characteristics

$Q_{G(ON)}$	Gate Charge	$I_C = 10A, V_{CE} = 12V,$ $V_{GE} = 5V,$ See Fig. 14		-	32	-	nC
$V_{GE(TH)}$	Gate to Emitter Threshold Voltage	$I_C = 1.0mA,$	$T_C = 25^{\circ}C$	1.3	-	2.2	V
		$V_{CE} = V_{GE},$ See Fig. 10	$T_C = 150^{\circ}C$	0.75	-	1.8	V
V_{GEP}	Gate to Emitter Plateau Voltage	$I_C = 10A, V_{CE} = 12V$		-	3.0	-	V

Switching Characteristics

$t_{\text{d(ON)R}}$	Current Turn-On Delay Time-Resistive	$V_{\text{CE}} = 14\text{V}$, $R_L = 1\Omega$, $V_{\text{GE}} = 5\text{V}$, $R_G = 1\text{K}\Omega$, $T_J = 25^\circ\text{C}$, See Fig. 12	-	0.7	4	μs
t_{rR}	Current Rise Time-Resistive		-	2.1	7	μs
$t_{\text{d(OFF)L}}$	Current Turn-Off Delay Time-Inductive	$V_{\text{CE}} = 300\text{V}$, $L = 2\text{mH}$, $V_{\text{GE}} = 5\text{V}$, $R_G = 1\text{K}\Omega$, $T_J = 25^\circ\text{C}$, See Fig. 12	-	10.8	15	μs
t_{fL}	Current Fall Time-Inductive		-	2.8	15	μs
SCIS	Self Clamped Inductive Switching	$T_J = 25^\circ\text{C}$, $L = 670\mu\text{H}$, $R_G = 1\text{K}\Omega$, $V_{\text{GE}} = 5\text{V}$, See Fig. 1 & 2	-	-	500	mJ

Thermal Characteristics

$R_{\theta\text{JC}}$	Thermal Resistance Junction-Case	TO-263, TO-220, TO-262	-	-	0.6	$^\circ\text{C/W}$
-----------------------	----------------------------------	------------------------	---	---	-----	--------------------

Typical Characteristics

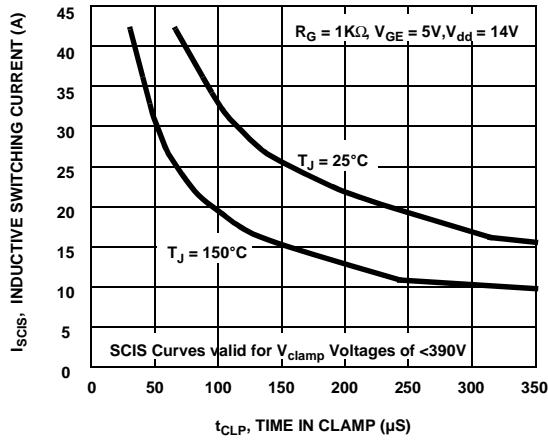


Figure 1. Self Clamped Inductive Switching Current vs Time in Clamp

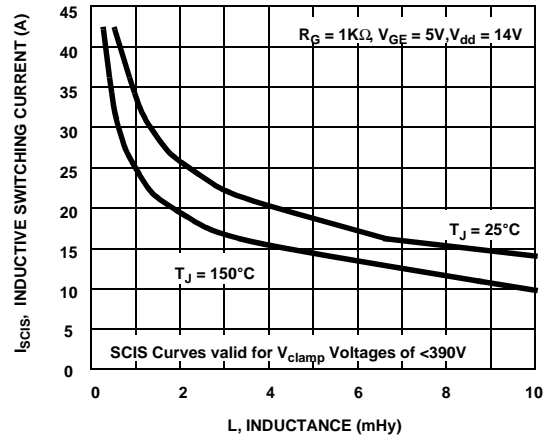


Figure 2. Self Clamped Inductive Switching Current vs Inductance

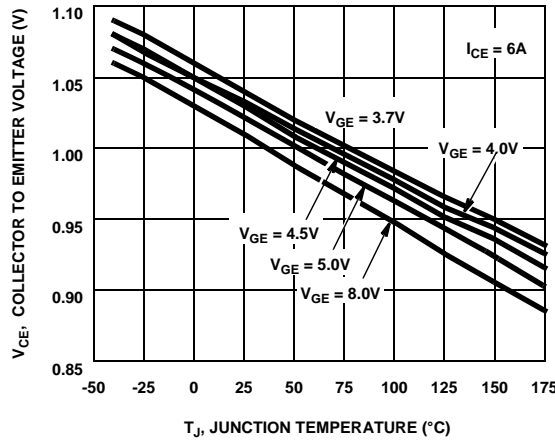


Figure 3. Collector to Emitter On-State Voltage vs Junction Temperature

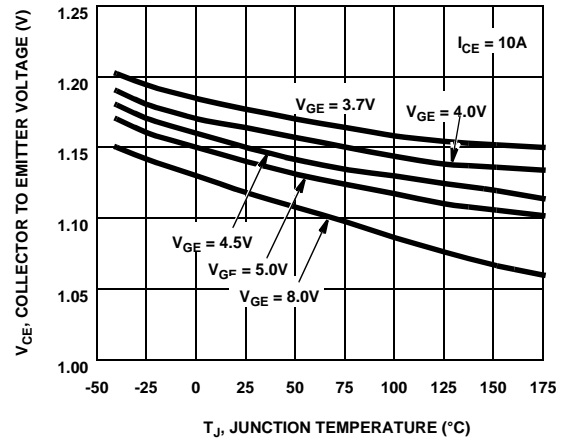


Figure 4. Collector to Emitter On-State Voltage vs Junction Temperature

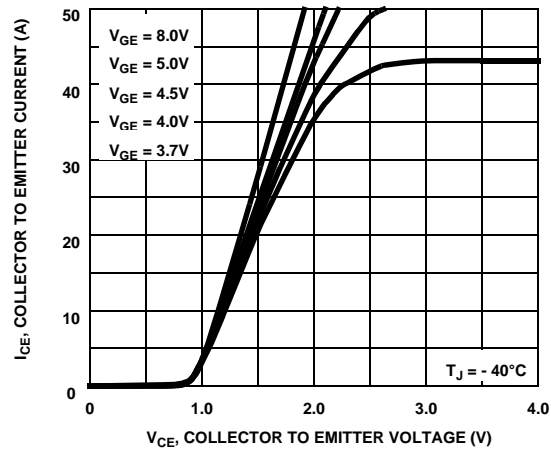


Figure 5. Collector Current vs Collector to Emitter On-State Voltage

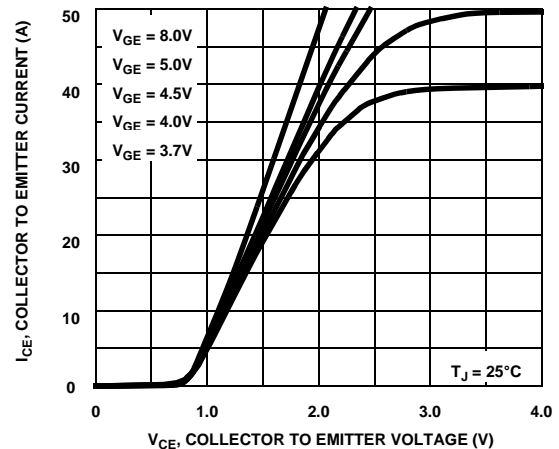


Figure 6. Collector Current vs Collector to Emitter On-State Voltage